

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/637,713	<b>Applicant(s)/Patent under Reexamination</b> LANDREVILLE ET AL.
	<b>Examiner</b> (Jackie) Tan-Uyen T. Ho	<b>Art Unit</b> 3731

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner